Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/763,747	TACHAUER ET AL.	
Examiner	Art Unit	
Mark Eashoo, Ph.D.	1732	

SEARCHED				
Class	Subclass	Date <sup>1</sup>	Examiner	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR			
4/2/2006	ME			
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